

## 2SC3847

### Silicon High Speed Power Transistor

2SC3847 800V, 10A

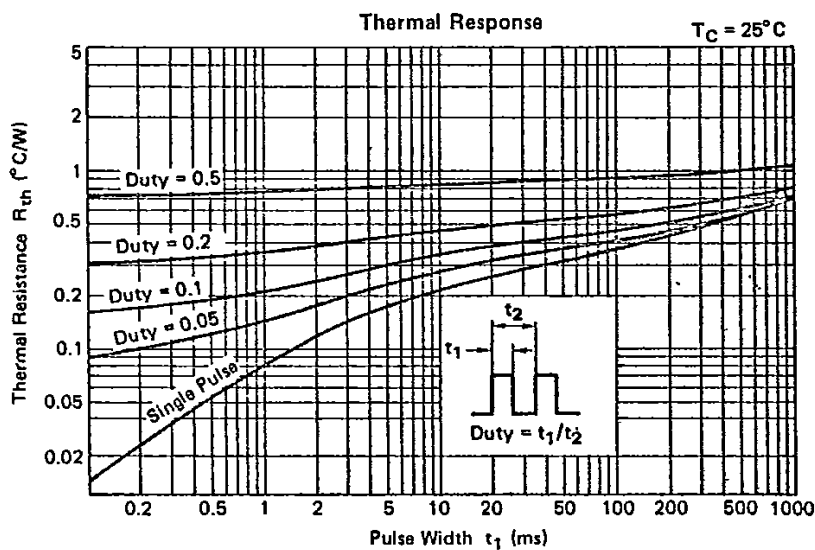
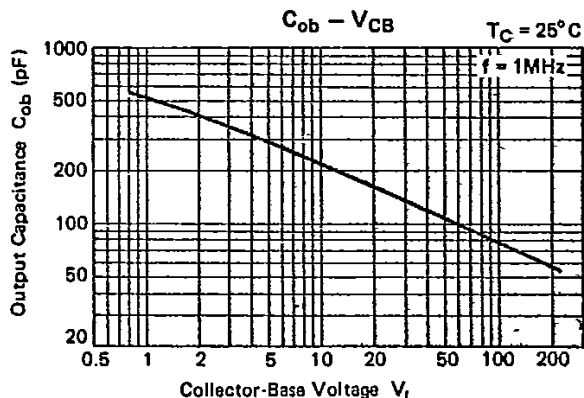
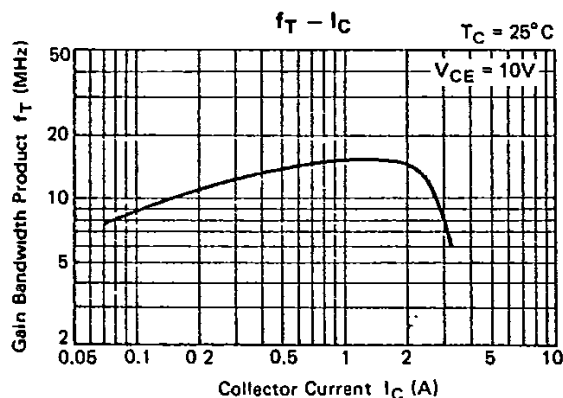
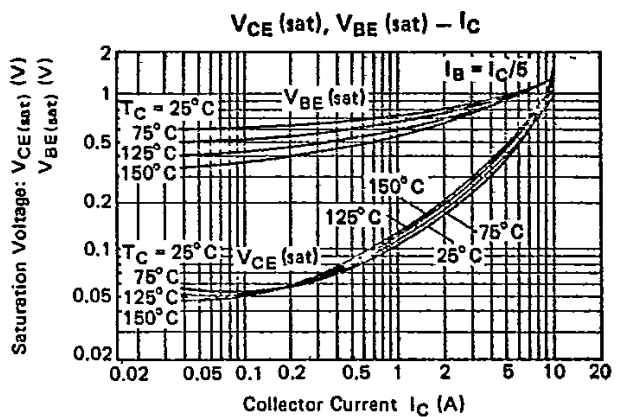
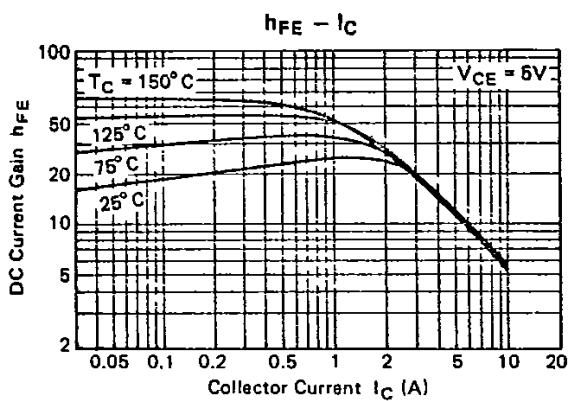
#### ABSOLUTE MAXIMUM RATINGS

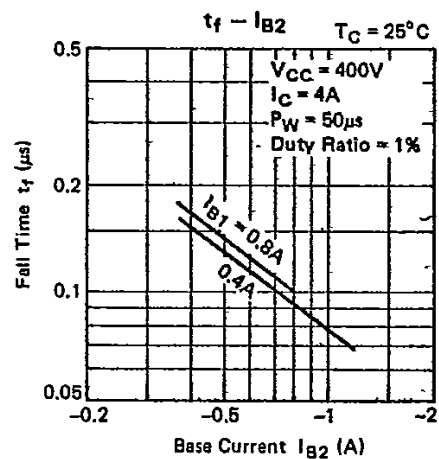
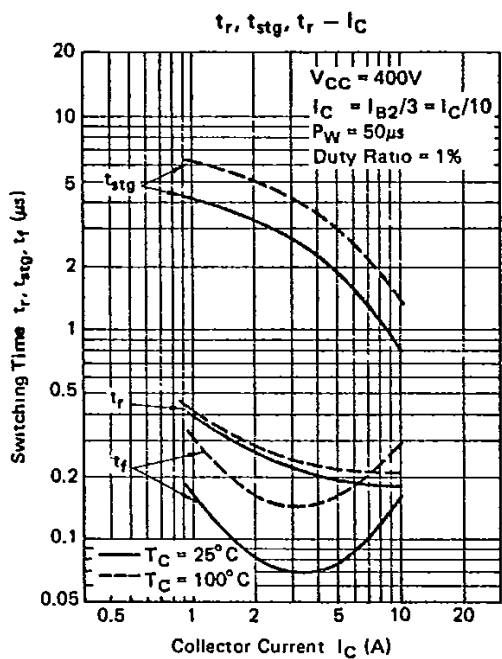
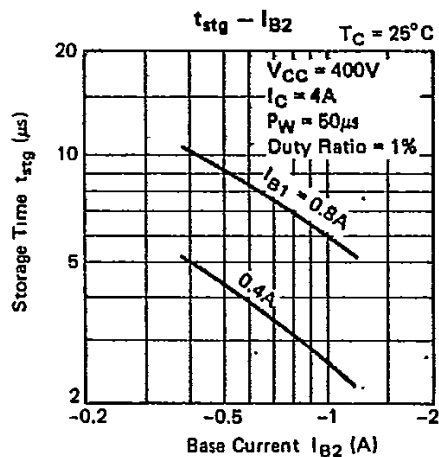
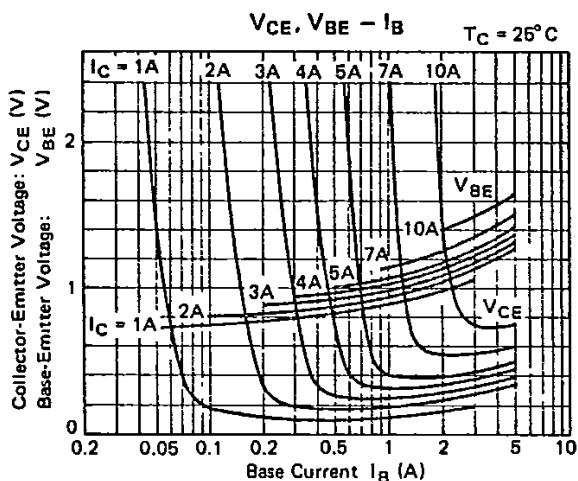
Parameter	Symbol	Conditions	Rating	Unit
Storage Temperature Range	$T_{stg}$		-55 ~ +150	°C
Junction Temperature	$T_J$		+150	°C
Collector to Base Voltage	$V_{CBO}$		1200	V
Emitter to Base Voltage	$V_{EBO}$		7	V
Collector to Emitter Voltage	$V_{CEO}$		800	V
Collector Current	$I_C$		10	A
	$I_{CM}$	$P_W \leq 25\mu s, D.R. \leq 50\%$	20	
Base Current	$I_B$		5	A
Collector Power Dissipation	$P_C$	$T_C = 25^\circ C$	85	W

#### ELECTRICAL CHARACTERISTICS ( $T_a = 25^\circ C$ )

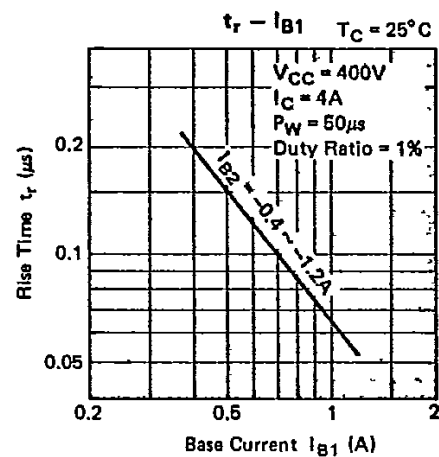
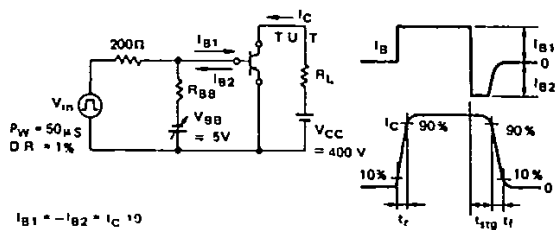
Parameter	Symbol	Test Conditions	Limit			Unit
			Min.	Typ.	Max.	
Collector to Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C = 1mA, I_E = 0$	1200	-	-	V
Emitter to Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E = 1mA, I_C = 0$	7	-	-	V
Collector to Emitter Sustaining Voltage	$V_{(BR)CEO}$	$I_C = 10mA, R_{BE} = \infty\Omega$	800	-	-	V
Collector to Emitter Sustaining Voltage	$V_{CEX(SUS)}$	$I_C = 7A, I_{B2} = -1.2A, L = 1mH^*$	900	-	-	V
Collector Cutoff Current	$I_{CBO}$	$V_{CB} = 1000V, I_E = 0$	-	-	100	$\mu A$
		$V_{CB} = 1000V, I_E = 0, T_C = 100^\circ C$	-	-	1	mA
Emitter Cutoff Current	$I_{EBO}$	$V_{EB} = 6V, I_C = 0$	-	-	100	$\mu A$
DC Current Gain	$h_{FE}$	$V_{CE} = 5V, I_C = 4A^{**}$	10	15	30	-
Collector to Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 4A, I_B = 0.8A^{**}$	-	0.3	1.5	V
Base to Emitter Saturation Voltage	$V_{BE(sat)}$		-	1.0	2.0	V
Output Capacitance	$C_{ob}$	$V_{CB} = 10V, I_E = 0, f = 1MHz$	-	220	-	pF
Gain Bandwidth Product	$f_T$	$V_{CE} = 10V, I_C = 0.1A$	-	15	-	MHz
Rise Time	$t_r$	$V_{CC} = 400V, I_C = 4A, 3I_{B1} = -I_{B2} = 1.2A^*$	-	0.20	0.5	$\mu s$
Storage Time	$t_{stg}$		-	2.50	3.5	$\mu s$
Fall Time	$t_f$		-	0.07	0.3	$\mu s$

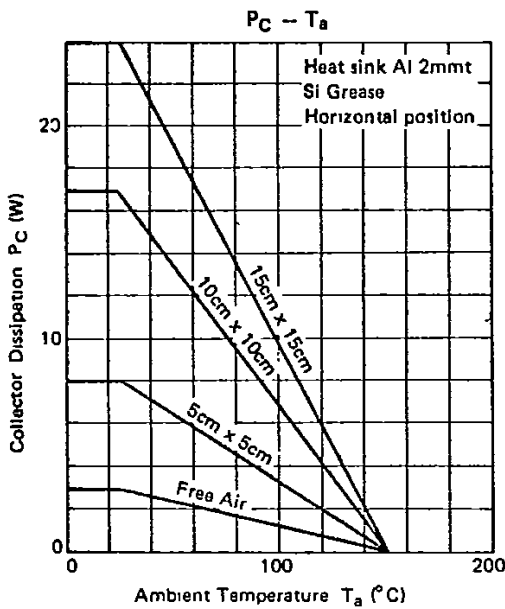
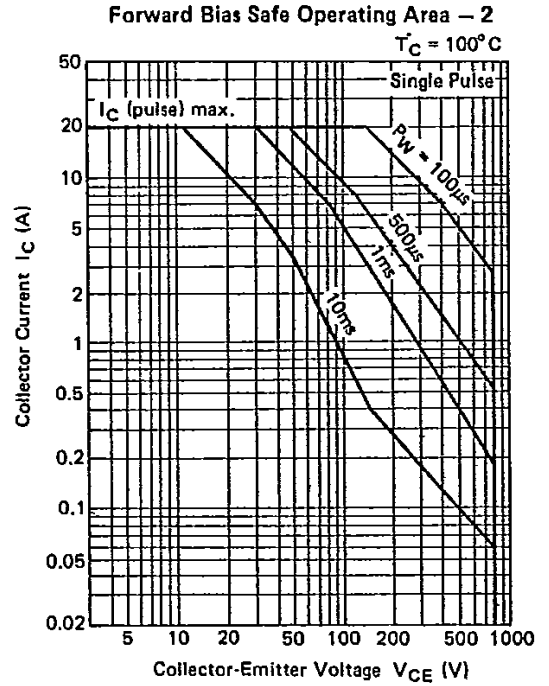
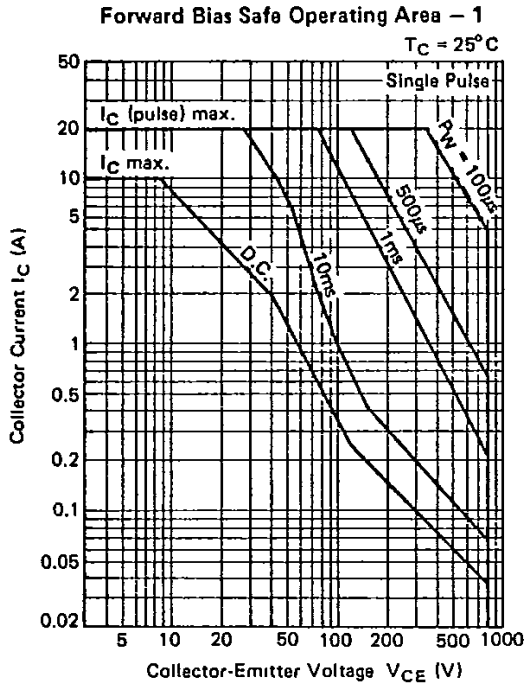
\*1 Test Circuit \*\*2 Pulse  $P_W \leq 300\mu s, Duty Ratio \leq 6\%$



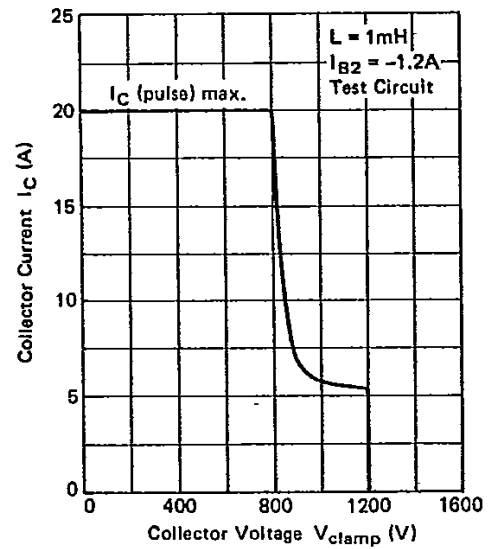


Test Circuit for Switching Time

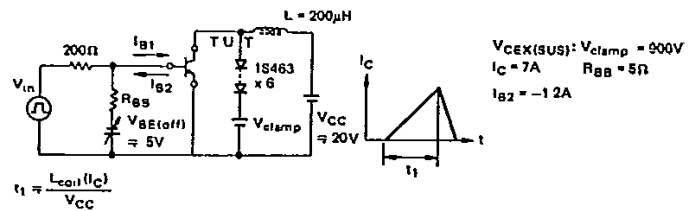




**Reverse Bias Safe Operating Area**



**Test Circuit for  $V_{CEX(sus)}$  and Reverse Bias Safe Operating Area**



**TO-3PF FULL PLASTIC MOLD POWER TRANSISTORS  
(RING EMITTER TRANSISTORS)**

**ELECTRICAL CHARACTERISTICS**

Type No.	Maximum Ratings ( $T_a = 25^\circ\text{C}$ )					Electrical Characteristics ( $T_a = 25^\circ\text{C}$ )			
	$V_{CBO}$ (V)	$V_{CEO}$ (V)	$I_C$ (A)	$I_{CM}^*$ (A)	$P_C$ (W)			$h_{FE}$ Min.	$t_f$ ( $\mu\text{s}$ ) Max.
						$V_{CE}$ (V)	$I_C$ (A)		
2SC3842	600	400	10	15	70	5	5	10	0.3
2SC3843	600	450	10	20	75	5	6	10	0.2
2SC3844	600	450	15	20	75	5	10	10	0.3
2SC3845	1200	800	3	6	75	5	1	10	0.3
2SC3846	1200	800	6	10	80	5	2	10	0.3
2SC3847	1200	800	10	20	85	5	4	10	0.3
2SC3947	850	500	5	8	70	5	2.5	10	0.3
2SC3948	850	500	10	15	75	5	5	10	0.3
2SC3949	850	500	15	20	80	5	10	10	0.3

\* Pulsed  $P_W \leq 25\mu\text{s}$ , D.R.  $\leq 50\%$

● Package Outline and Terminal Configuration

